Application/Control No. Applicant(s)/Patent Under Reexamination 10/081,210 LEE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Peter Choi 3623 **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2003/0126043 07-2003 705/28 Chen et al. Α * US-2003/0101110 05-2003 Chen et al. 705/29 В US-С US-D US-Ε US-F US-G US-Н US-١ US-US-Κ

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